



Attorney's Docket No.: 05542-459003 / 5353C1/CMP

Image 41763

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Wallace T.Y. Tang Art Unit : 1763
Serial No. : 09/134,147 Examiner : Sylvia R. MacArthur
Filed : August 14, 1998
Title : IN-SITU REAL-TIME MONITORING TECHNIQUE AND APPARATUS FOR
DETECTION OF THIN FILMS DURING CHEMICAL/MECHANICAL
POLISHING PLANARIZATION

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicant submits the references listed on the attached form PTO-1449. A copy of a communication from a foreign patent office in a counterpart application and partial translations are also enclosed.

This statement is being filed after a non-final office action on the merits, but before prosecution has been closed. A final office action was mailed on October 3, 2003, but the Examiner withdrew the finality by issuing a non-final office action on February 20, 2004. Please apply the \$180 fee pursuant to sections 1.97(c)(2) and 1.17(p), as well as any other charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: 10 March 2024

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03/16/2004 EAREGAY1 00000058 061050 09134147
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I hereby certify under 37 CFR §1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated below and is addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

March 10, 2004
Date of Deposit
Carlos A. Brasil

Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office		Attorney's Docket No. 05542-459003	Application No. 09/134,147
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))				Applicant Wallace T.Y. Tang	
				Filing Date August 14, 1998	Group Art Unit 1763

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation
							Yes No
	AL	H02-86128	07/1990	JP			Partial Translation
	AM	H05-69311	03/1993	JP			Partial Translation
	AN						
	AO						
	AP						

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	